

Form PTO-1449

**LIST OF PATENTS AND PUBLICATIONS FOR
APPLICANT'S INFORMATION DISCLOSURE STATEMENT**

(Use several sheets if necessary)

ATTORNEY DOCKET NO.
20020821-2SERIAL NO.
10/332776APPLICANT
Christian HENTSCHEL et alFILING DATE
HerewithGROUP
2112**REFERENCE DESIGNATION****U.S. PATENT DOCUMENTS**

EXAMINER INITIAL	*	DOCUMENT NUMBER	DATE	NAME

FOREIGN PATENT DOCUMENT

		DOCUMENT NUMBER	DATE	NAME	TRANSLATION YES NO
IA		EP 0536538A2	04/14/1993	Hewlett-Packard Company	N/A
IA		EP 0654657A2	05/24/1995	AT & T Corp.	N/A

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)

IA	Rex M. Craig et al, "High-Resolution, Nonmechanical Approach to Polarization-Dependent Transmission Measurements", Journal of Lightwave Technology, Vol. 16, No. 7, July 1998, pp 1285-1294
IA	B.L. Heffner, "Deterministic, Analytically Complete Measurement of Polarization-Dependent Transmission Through Optical Devices", IEEE Photonics Technology Letters, Vol. 4, No. 5., May 1992, pp 451-454
IA	Christian Hentschel et al, "PDL Measurements using the Agilent 8169A Polarization Controller" Product Note, Agilent Technologies, January 9, 2002, pp 1-14
IA	"Polarization-dependent loss measurements using modular test system configurations", Product Note, Agilent Technologies, 1996, pp 1-14
IA	K. Bohm et al, "Performance of Lyot Depolarizers with Birefringent Single-Mode Fibers", Journal of Lightwave Technology, Vol. LT-1, No. 1, March 1983, pp 71-74
IA	EP Search Report, 24 June 2003

EXAMINER

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DATE CONSIDERED

01/10/2007

* Copies of these references are not enclosed Pursuant to 37 CFR 1.98(d). (See accompanying IDS)